

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/056,005	KARINO ET AL.	
Examiner	Art Unit	
Kerri M. Rose	2616	

	SEARCHED				
Class	Subclass	Date	Examiner		
370	229-233	10/26/2005	KMD		
	235				
	236				
370	328-329	10/28/2005	KMD		
	408				
Above	UPDATED	2/15/2006	KMD		
455	422.1	2/15/2006	KMD		
455	436	2/15/2006	KMD		
Above	Updated	5/30/2006	KMD		
Above	Updated	9/20/2006	KMR		

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
		-				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East	10/31/2005	KMD		
STIC PLUS	10/27/2005	KMD		
IEEE and ACM - see printout	10/28/2005	KMD		
East - see printout	2/15/2006	KMD		
East - see printout	5/30/2006	KMD		
East - see printout	6/1/2006	KMD		
Combined citation search: 2002/0194361; 2004/0095882	6/1/2006	KMD		
East - see printout	9/20/2006	KMR		